

NTE5538 Silicon Controlled Rectifier (SCR) 800V_{DRM}, 50A

Description:

The NTE5538 general purpose SCR is suited for power supplies up to 400Hz on resistive or inductive loads.

Features:

- Glass Passivated Chip
- High Stability and Reliability
- High Surge Capability
- High On-State Current
- Easy Mounting on Heatsink
- Isolated Package: Insulating Voltage 2500V_{RMS}

Absolute Maximum Ratings:

Peak Forward Blocking Voltage ($T_J = +125^{\circ}\text{C}$), V_{DRM}	800V
Peak Reverse Blocking Voltage ($T_J = +125^{\circ}\text{C}$), V_{RRM}	800V
RMS On-State Current ($T_C = +70^{\circ}\text{C}$, Note 1), $I_{\text{T(RMS)}}$	50A
Average On-State Current ($T_C = +70^{\circ}\text{C}$, Note 1), $I_{\text{T(AV)}}$	32A
Non-Repetitive Surge Peak On-State Current (T_J initial = $+25^{\circ}\text{C}$, Note 2), I_{TSM}	
($t = 8.3\text{ms}$)	525A
($t = 10\text{ms}$)	500A
I^2t Value ($t = 10\text{ms}$), I^2t	1250A ² sec
Critical Rate of Rise of On-State Current (Note 3), di/dt	100A/ μs
Storage and Operating Junction Temperature Range, T_{stg} , T_J	-40° to $+125^{\circ}\text{C}$
Thermal Resistance	
Junction-to-Case for DC, R_{thJC}	1 $^{\circ}\text{C/W}$
Contact (Case-to-Heatsink), R_{thCH}	0.2 $^{\circ}\text{C/W}$

Note 1. Single phase circuit, 180° conducting angle.

Note 2. Half sine wave.

Note 3. $I_G = 800\text{mA}$, $di_G/dt = 1\text{A}/\mu\text{s}$.

Gate Characteristics: (Maximum Values)

Peak Gate Power ($t = 10\mu\text{s}$), P_{GM}	50W
Average Gate Power Dissipation, $P_{\text{G(AV)}}$	1W
Peak Forward Gate Current ($t = 10\mu\text{s}$), I_{FGM}	2A
Peak Forward Gate Voltage ($t = 10\mu\text{s}$), V_{FGM}	15V
Peak Reverse Gate Voltage, V_{RGM}	5V

Electrical Characteristics: ($T_J = +25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Gate Trigger Current	I_{GT}	$V_D = 12\text{V}, R_L = 33\Omega, t_p \geq 20\mu\text{s}$	-	-	80	mA
Gate Trigger Voltage	V_{GT}		-	-	1.5	V
Gate Non-Trigger Voltage	V_{GD}	$T_J = +125^\circ\text{C}, V_D = 800\text{V}, R_L = 3.3\text{k}\Omega$	0.2	-	-	V
Holding Current	I_H	$I_T = 0.5\text{A}, \text{Gate Open}$	-	20	150	mA
Peak On-State Voltage	V_{TM}	$I_{TM} = 100\text{A}, t_p = 10\text{ms}$	-	-	1.9	V
Forward Leakage Current	I_{DRM}	$V_{DRM} = 800\text{V}$	-	-	0.02	mA
			$T_J = +125^\circ\text{C}$	-	-	6.0
Reverse Leakage Current	I_{RRM}	$V_{DRM} = 800\text{V}$	-	-	0.02	mA
			$T_J = +125^\circ\text{C}$	-	-	6.0
Total Turn-On Time	t_{gt}	$I_T = 80\text{A}, V_D = 800\text{V}, I_G = 200\text{mA}, di_G/dt = 0.2\text{A}/\mu\text{s}$	-	2	-	μs
Turn-Off Time	t_q	$T_J = +125^\circ\text{C}, I_T = 80\text{A}, V_R = 75\text{V}, V_D = 536\text{V}, di_R/dt = 30\text{A}/\mu\text{s}, dv/dt = 20\text{V}/\mu\text{s}, \text{Gate Open}$	-	100	-	μs
Critical Rate of Rise of Off-State Voltage	dv/dt	$T_J = +125^\circ\text{C}, V_{DRM} = 536\text{V}, \text{Gate Open}, \text{Linear Slope Up}$	500	-	-	$\text{V}/\mu\text{s}$

